

Notice of References Cited	Application/Control No. 10/520,349	Applicant(s)/Patent Under Reexamination NAGASAWA, ATSUSHI	
	Examiner HAMID R. BADR	Art Unit 4174	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Nakagawa, S. et al., 1994. Construction from a single parent of baker's yeast strains with high freeze tolerance and fermentative activity in both lean and sweet doughs. Appl. Environmental Microbiol. 60 (10): 3499-3502
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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